

INFORMATION DISCLOSURE CITATION <i>(Use several sheets if necessary)</i>				Docket Number (Optional) FIS9-2001-0254US1		Application Number 10/035,061		
				Applicant(s) AUSSCHNITT ET AL.				
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U.S. PATENT DOCUMENTS								
*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
U.S. PATENT APPLICATION PUBLICATIONS								
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FOREIGN PATENT DOCUMENTS								
	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO
OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>								
		SPIE 3697 - "Application of blazed gratings for determination of equivalent primary azimuthal aberrations" - Kirk and Progler - Proceedings SPIE, Vol. 3679, pp. 70 - 76, Date of Publication 1999, USA						
		SPIE 4000 - "Impact of high order aberrations on the performance of the aberration monitor" - Dirksen et al. - Proceedings SPIE, Vol. 4000, pp. 9 - 17, Date of Publication 2000, USA						
		SPIE 4000 - "In-situ measurement of lens aberrations" - Farrar et al. - Proceedings SPIE, Vol. 4000, pp. 18 - 29, Date of Publication 2000, USA						
EXAMINER				DATE CONSIDERED				
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